

<IGBT Modules>

CM1000HA-34S

HIGH POWER SWITCHING USE INSULATED TYPE

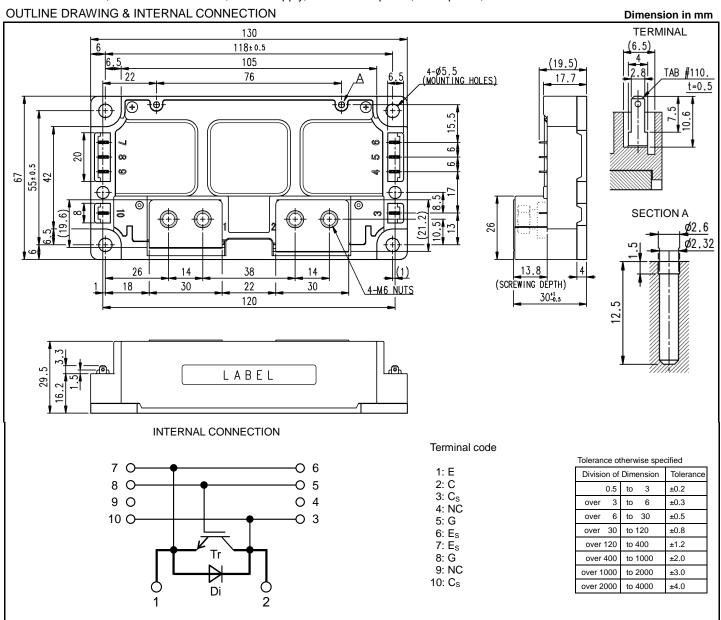


single pack

- Flat base Type
- •Copper base plate
- •Tin plating tab terminals
- •RoHS Directive compliant
- •Recognized under UL1557, File E323585

APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, Photovoltaic power, Wind power, etc.



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MAXIMUM RATINGS (Tvj=25 °C, unless otherwise specified)

Symbol	Item	Conditions	Rating	Unit	
V _{CES}	Collector-emitter voltage	G-E short-circuited	1700	V	
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V	
I _C	Collector current	DC, T _C =111 °C (Note2, 4)	1000	^	
I _{CRM}	Collector current	Pulse, Repetitive (Note3)	2000	_ A	
P _{tot}	Total power dissipation	T _C =25 °C (Note2, 4)	7140	W	
I _E (Note1)	Emitter current	DC (Note2)	1000	^	
I _{ERM} (Note1)	Emilier current	Pulse, Repetitive (Note3)	2000	A	
V _{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	4000	V	
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	- °C	
T _{Cmax}	Maximum case temperature	(Note4)	125		
T _{vjop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	- °C	
T _{stg}	Storage temperature	-	-40 ~ +125		

ELECTRICAL CHARACTERISTICS (Tvj=25 °C, unless otherwise specified)

Symbol	Itom	Conditions		Limits			l loit
Syllibol	Item			Min.	Тур.	Max.	Unit
I _{CES}	Collector-emitter cut-off current	V _{CE} =V _{CES} , G-E short-circuited		-	-	1.0	mA
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited		-	-	0.5	μA
$V_{GE(th)}$	Gate-emitter threshold voltage	I _C =100 mA, V _{CE} =10 V		5.4	6.0	6.6	V
V _{CEsat}		I _C =1000 A, V _{GE} =15 V,	T _{vj} =25 °C	-	2.10	2.60	V
		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.35	-	
(Terminal)	Only of an analysis and analysis and an analys	(Note5)	T _{vj} =150 °C	-	2.45	-	
	Collector-emitter saturation voltage	I _C =1000 A,	T _{vj} =25 °C	-	2.00	2.50	
V _{CEsat}		V _{GE} =15 V,	T _{vj} =125 °C	-	2.25	-	V
(Chip)		(Note5)	T _{vj} =150 °C		2.35	-	
Cies	Input capacitance		•	-	-	230	
Coes	Output capacitance	V _{CE} =10 V, G-E short-circuited		-	-	24	nF
Cres	Reverse transfer capacitance				-	4.0	
Q _G	Gate charge	V _{CC} =1000 V, I _C =1000 A, V _{GE} =15 V			4.2	-	μC
t _{d(on)}	Turn-on delay time	V 4000 V L 4000 A V 45 V		-	-	900	
tr	Rise time	V_{CC} =1000 V, I_{C} =1000 A, V_{GE} =±15 V, R_{G} =0 Ω, Inductive load		-	-	300	ns
t _{d(off)}	Turn-off delay time			-	-	900	
t _f	Fall time			-	-	400	
(Note 4)	Farther all states the	I _E =1000 A, G-E short-circuited,	T _{vj} =25 °C	-	2.10	2.60	V
V _{EC} (Note.1)		Refer to the figure of test circuit	T _{vj} =125 °C	-	2.20	-	
(Terminal)		(Note5)	T _{vj} =150 °C	-	2.15	-	
(Note 4)	Emitter-collector voltage	I _E =1000 A,	T _{vj} =25 °C	-	2.00	2.50	
V _{EC} (Note.1)		G-E short-circuited,	T _{vj} =125 °C	-	2.10	-	V
(Chip)		(Note5)	T _{vj} =150 °C	-	2.05	-	
t _{rr} (Note1)	Reverse recovery time	V _{CC} =1000 V, I _E =1000 A, V _{GE} =±15 V,		-	-	500	ns
Q _{rr} (Note1)	Reverse recovery charge	$R_G=0 \Omega$, Inductive load		-	200	-	μC
Eon	Turn-on switching energy per pulse	V_{CC} =1000 V, I_{C} = I_{E} =1000 A, V_{GE} =±15 V, R_{G} =0 Ω , T_{vj} =150 °C,		-	589	-	
E _{off}	Turn-off switching energy per pulse			-	253	-	mJ
E _{rr} (Note1)	Reverse recovery energy per pulse	Inductive load		-	245	-	mJ
R _{CC'+EE'}	Internal lead resistance	Main terminals-chip, T _C =25 °C (Note4)		-	0.2	-	mΩ
r _g	Internal gate resistance	-	-	2.2	-	Ω	

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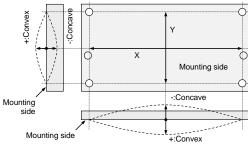
THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
		Conditions	Min.	Тур.	Max.	Unit
R _{th(j-c)Q}	Thermal resistance	Junction to case, IGBT (Note4)	-	=	21	K/kW
R _{th(j-c)D}		Junction to case, FWD (Note4)	-	-	32	r/KVV
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, Thermal grease applied (Note4, 6)	-	18	-	K/kW

MECHANICAL CHARACTERISTICS

Cymbol	Item	Conditions		Limits			Unit	
Symbol				Min.	Тур.	Max.	Onit	
M _t	Mounting torque	Main terminals	M 6 screw	3.5	4.0	4.5	N∙m	
Ms	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N∙m	
٦	Creepage distance	Terminal to terminal		22.0	=	-		
d _s		Terminal to base plate		21.9	=	-	mm	
da	Clearance	Terminal to terminal		16.5	=	-		
		Terminal to base plate		12.5	=	-	mm	
ec	Flatness of base plate	On the centerline X, Y (Note7)		-50	-	+100	μm	
m	mass	-		-	490	-	g	

- *: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.
- Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).
 - 2. Junction temperature (T_{vj}) should not exceed T_{vjmax} rating.
 - 3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed T_{vjmax} rating.
 - 4. Case temperature (T_C) and heat sink temperature (T_S) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.
 - 5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
 - 6. Typical value is measured by using thermally conductive grease of λ =0.9 W/(m·K)/D_(C-S)=100 μ m.
 - 7. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



8. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

The length of the screw depends on the PCB thickness (t1.0).

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	Туре	Size	Tightening torque	Recommended tightening method				
(1)	PT®	K25×8	0.55 ± 0.055 N·m					
(2)	PT®	K25×10	0.85 ± 0.085 N·m	by handwork (equivalent to 30 r/min				
(3)	DELTA PT®	25×8	0.55 ± 0.055 N·m	by mechanical screw driver)				
(4)	DELTA PT®	25×10	0.85 ± 0.085 N·m	~ 600 r/min (by mechanical screw driver)				
(5)	B1 tapping screw	φ2.6×10 or φ2.6×12	0.85 ± 0.085 N·m					

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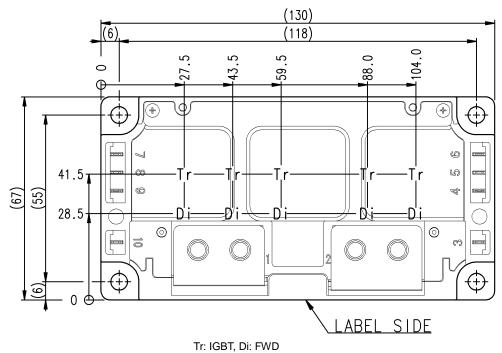
INSULATED TYPE

RECOMMENDED OPERATING CONDITIONS

Symbol	Item Conditions	Conditions	Limits			Unit
		Conditions	Min.	Тур.	Max.	Offic
V _{cc}	(DC) Supply voltage	Applied across C-E terminals	-	1000	1200	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G-Es terminals	13.5	15.0	16.5	V
R _G	External gate resistance	-	0	-	15	Ω

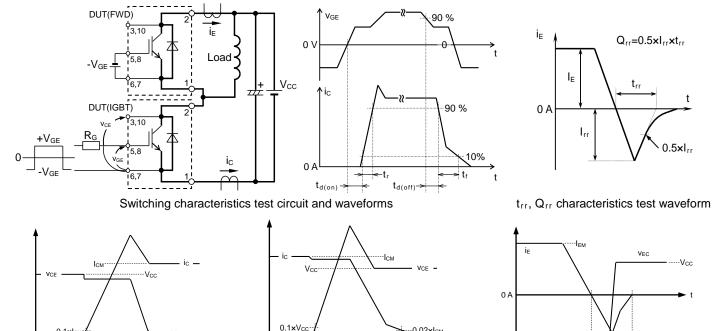
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm



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TEST CIRCUIT AND WAVEFORMS



IGBT Turn-off switching energy Turn-on / Turn-off switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

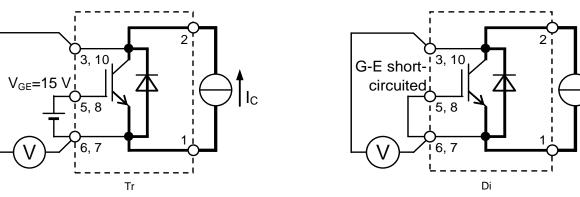
0 V

FWD Reverse recovery energy

ΙE

TEST CIRCUIT

IGBT Turn-on switching energy



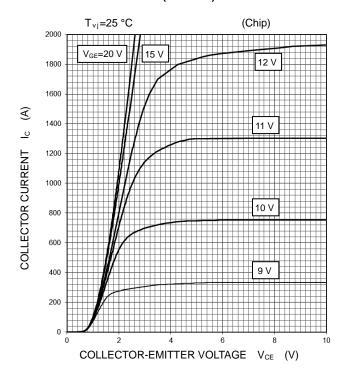
V_{CEsat} characteristics test circuit V_{EC} characteristics test circuit

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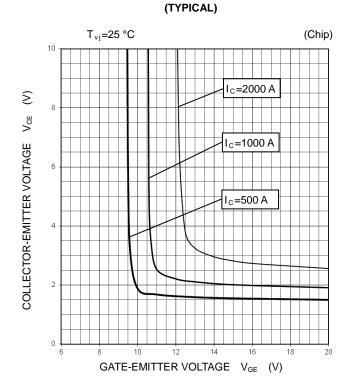
INSULATED TYPE

PERFORMANCE CURVES OUTPUT CHARACTERISTICS

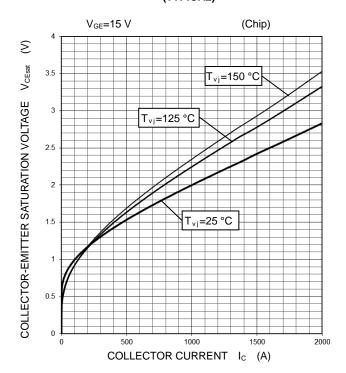
(TYPICAL)



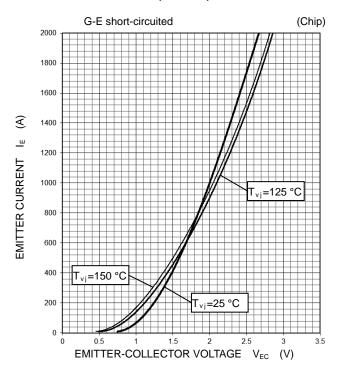
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



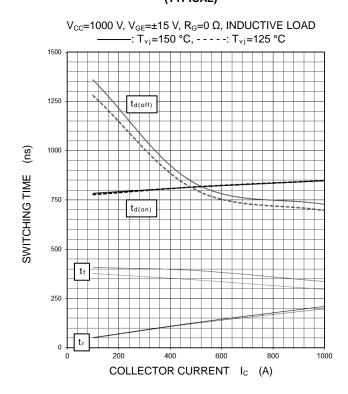
FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



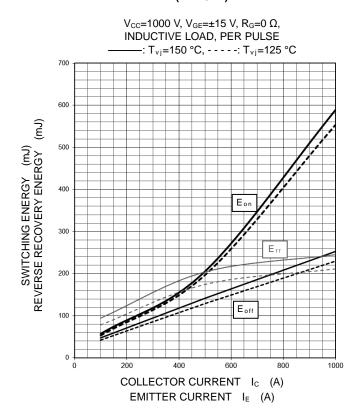
HIGH POWER SWITCHING USE

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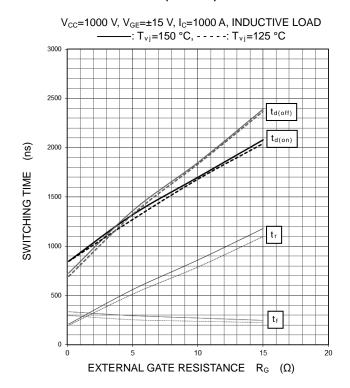
PERFORMANCE CURVES HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



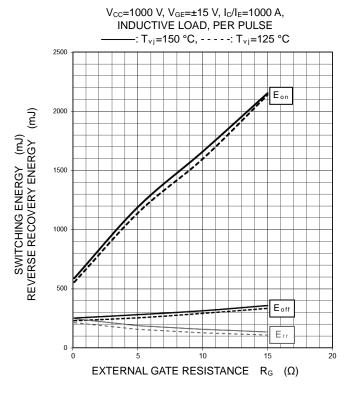
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



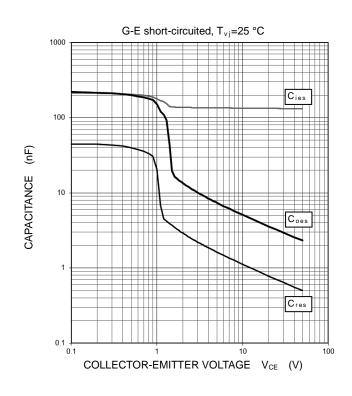
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)



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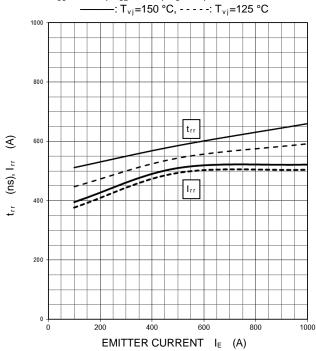
PERFORMANCE CURVES CAPACITANCE CHARACTERISTICS

(TYPICAL)



FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

V_{CC}=1000 V, V_{GE}=±15 V, R_G=0 Ω, INDUCTIVE LOAD

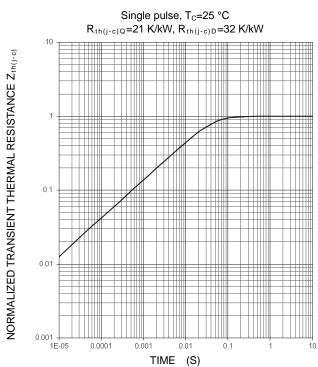


GATE CHARGE CHARACTERISTICS (TYPICAL)

 V_{CC} =1000 V, I_{C} =1000 A, T_{vj} =25 °C

GATE-EMITTER VOLTAGE VGE (V)

TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



GATE CHARGE Q_G (nC) TIME (S) Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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Keep safety first in your circuit designs!

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